

<b>Notice of References Cited</b>	Application/Control No. 10/811,699	Applicant(s)/Patent Under Reexamination BOTTOMLEY ET AL.	
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*	B	US-6,990,137	01-2006	Smee et al.	375/142
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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